

Notice of References Cited

Application/Control No.

09/772,779

Applicant(s)/Patent Under
Reexamination
CHEN ET AL.

Examiner

Betsy L. Deppe

Art Unit

2634

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,754,583	05-1998	Eberhardt et al.	375/147
	B	US-6,097,972	08-2000	Saints et al.	455/572
	C	US-6,208,699 B1	03-2001	Chen et al.	375/340
	D	US-6,621,808 B1	09-2003	Sadri, Ali S.	370/335
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

TQ